	Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/781,327	WANG ET AL.	
Examiner	Art Unit	
Hong Cho	2616	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	311, 335, 342, 441	7/2/2007	нс
455	522, 69	7/2/2007	нс

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
370/311, 335, 342, 441; 455/522,69 (text search - see search history printout)	7/2/2007	нс